

Search Notes



Application/Control No.

10/691,867

Examiner

Emmanuel Sayoc

Applicant(s)/Patent under Reexamination

KIM ET AL.

Art Unit

3746

SEARCHED

Class	Subclass	Date	Examiner
417	412	10/11/05	BSJ
	443.1		
	413.6x		
	521	10/12/05	BS
137	596.17x		BS
251	129.06x		
	357		
	129.01	10/12/05	BS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
417 - free 137/251 - Rivell	10/12/05	BS
see east txt search	10/12/05	BS